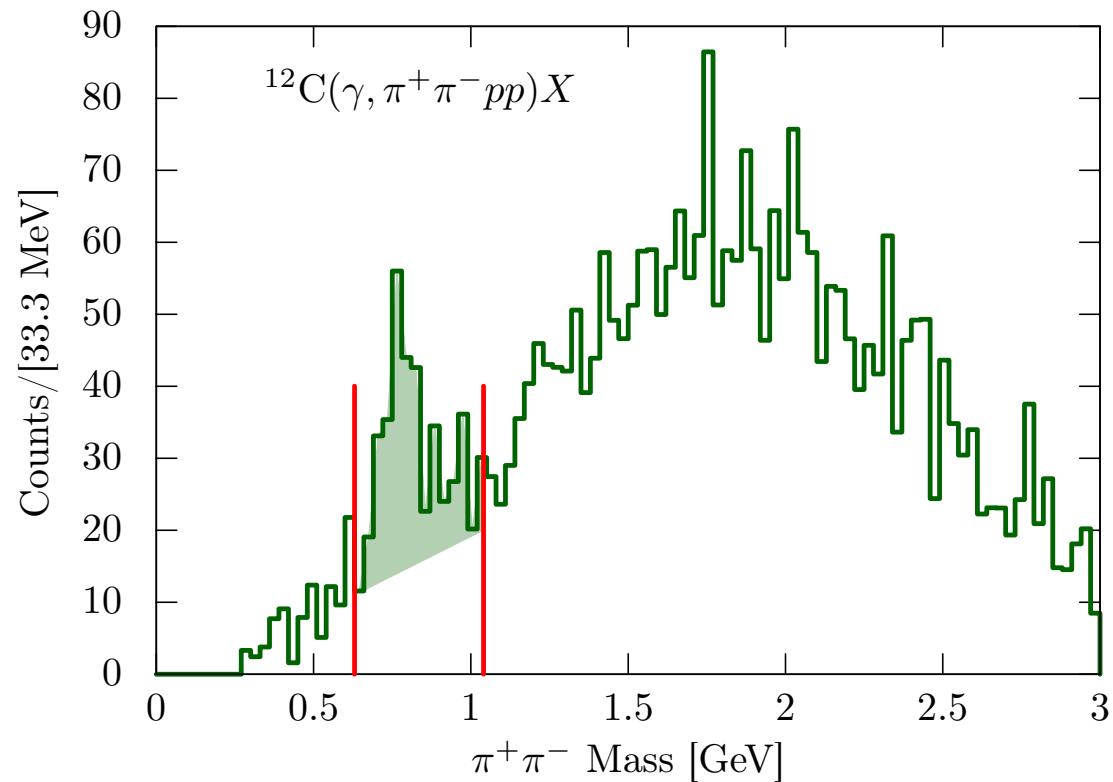


Executive Summary

- I have calculated the yield of $^{12}C(\gamma, \pi^+\pi^- pp)X$ three different ways.
 - Trapezoid Subtraction
 - Sideband Subtraction
 - Gauss Approximation with linear background

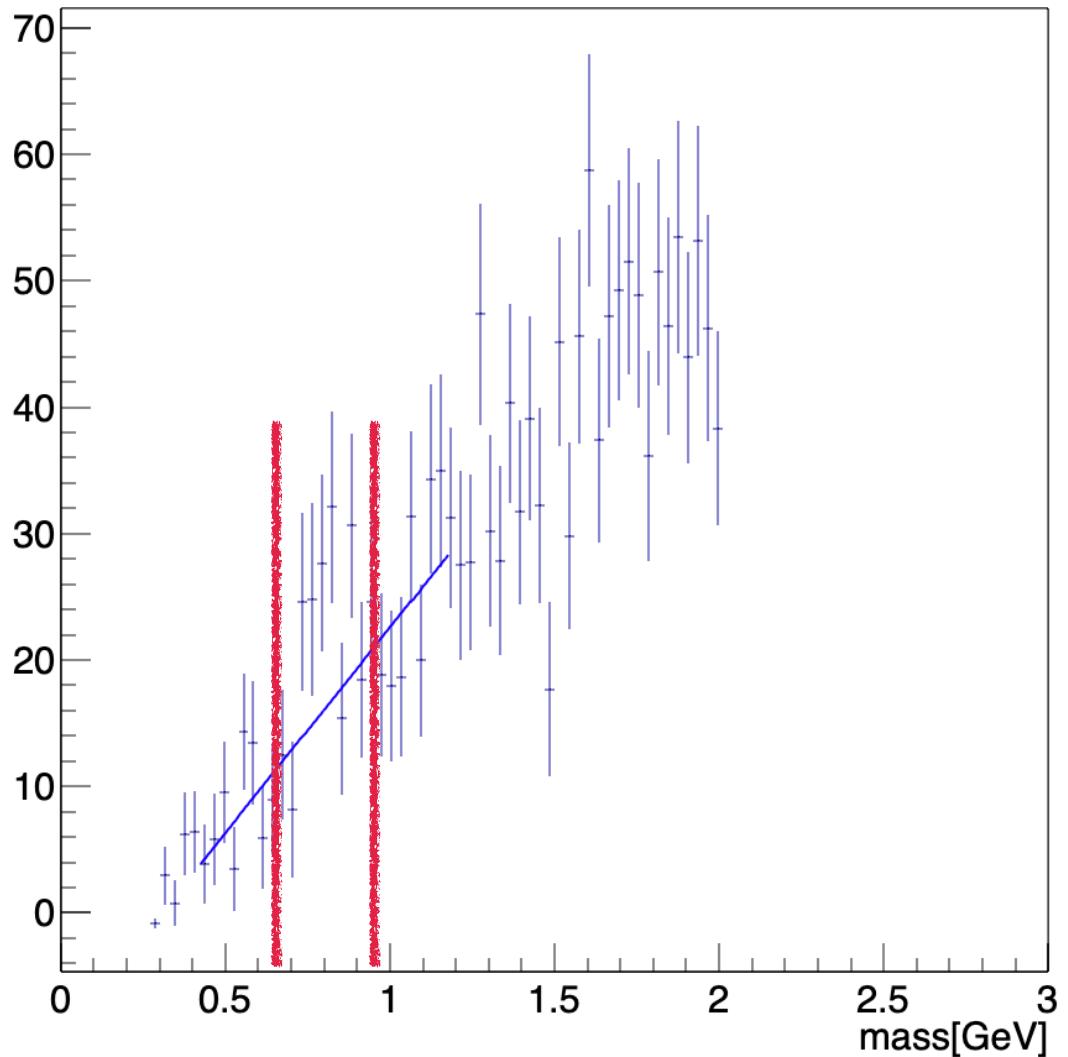
Trapezoid Subtraction

- Method: Integrate in signal region, subtract out background that makes trapezoids with red lines.
- Error is sum of integral error (bin errors) + error of left and right most bin.



Sideband Subtraction

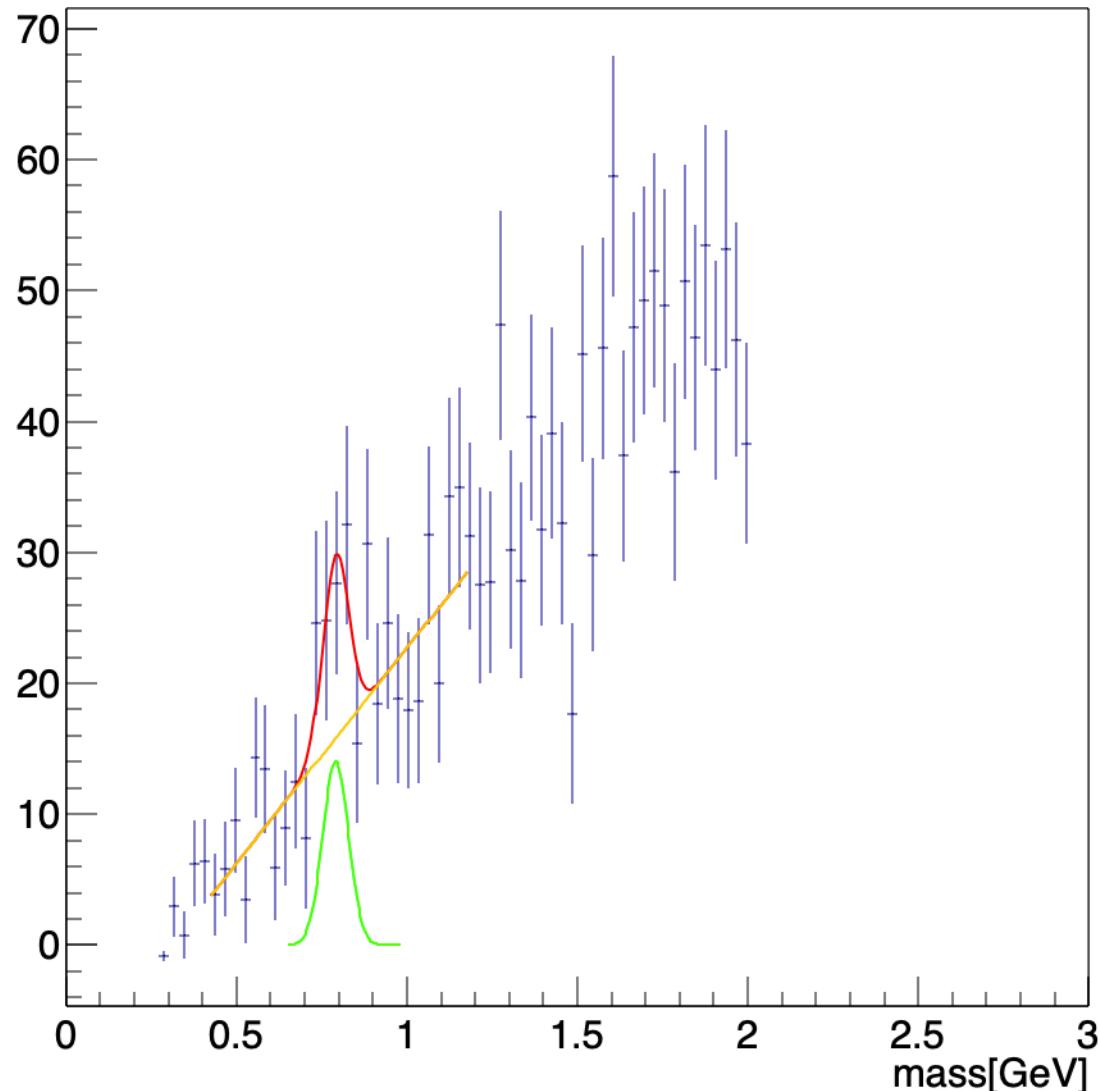
- Method: Fit line to the background, integrate in signal region, subtract
- Error is propagated from bin errors, assumed uncorrelated
IntegralAndError
- Next step: Add in correlated errors



Gaussian Approximation Method

with linear background

- Method: Fit a gauss in the signal region, subtract linear background
- Error on linear background parameters comes from covariance matrix



C12-2p

| pmiss (MeV) | Trapezoid | Sideband | Gaus |
|----------------|------------|--------------------------------|--------------------------------|
| 400-500 | 101 +/- 27 | 166 +/- 24 Chi2/Ndf = 35/13 | 138 +/- 25 Chi2/Ndf = 18/20 |
| 500-600 | 59 +/- 28 | 158 +/- 25 Chi2/Ndf = 32/13 | 154 +/- 29 Chi2/Ndf = 27/20 |
| 600-700 | 133 +/- 27 | 130 +/- 24 Chi2/Ndf = 24/13 | 140 +/- 32 Chi2/Ndf = 22/20 |
| 700-800 | 14 +/- 24 | 49 +/- 22 Chi2/Ndf = 19/13 | 44 +/- 18 Chi2/Ndf = 17/20 |

Next Steps

- Run $^{12}C(\gamma, \pi^+\pi^-p)X$ through this analysis and determine which method of yield calculation is best for $^{12}C(\gamma, \pi^+\pi^-p)X$.
- Take ratio of $\frac{^{12}C(\gamma, \pi^+\pi^-pp)X}{^{12}C(\gamma, \pi^+\pi^-p)X0T + ^{12}C(\gamma, \pi^+\pi^-pp)X}$ for np-dominance test